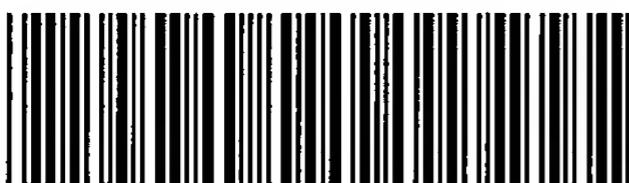


Search Notes**Application/Control No.**

10/649,918

Examiner

Syed Zaidi

Applicant(s)/Patent under Reexamination

OKA ET AL.

Art Unit

2609

SEARCHED

Class	Subclass	Date	Examiner
370	338	3/6/2007	SZ
370	328	3/6/2007	SZ
370	310	3/6/2007	SZ
709	212	3/6/2007	SZ
709	215	3/6/2007	SZ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (please see search history)	3/6/2007	SZ
Kazuyuki Oka Yokohamashi	3/6/2007	SZ
(370/338 370/328 370/310).ccls.	3/6/2007	SZ
(709/212 790/215).ccls.	3/6/2007	SZ
(IEEE Xplore Database(http://ieeexplore.ieee.org/Xplore/DynWel.jsp))	3/6/2007	SZ
Consulted with SPE Rafael Perez-Gutierrez and SPE Asst George Bugg	3/6/2007	SZ
(710/52 710/54).ccls.	3/6/2007	SZ